

QS800SGL330A3S: 3300V/800A IGBT Power Module



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Features

- Low VCE(sat) SPT IGBT technology
- Low switching losses
- 10μs short circuit capability
- VCE(sat) with positive temperature coefficient
- AlSiC baseplate for high power cycling capability
- AlN substrate for low thermal resistance
- High reliability package

Applications

- High Power Converter
- Wind Power
- Traction Drive

Key Values

PARAMETER	VALUE
VOLTAGE (COLLECTOR EMITTER)	3300V
CURRENT	800A

Part Number

QS800SGL330A3S

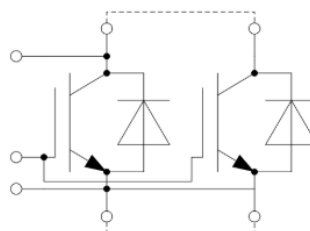
Package

Plastic package

Marking

Q

Package



ROHS Compliant
REACH Compliant



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ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$ Unless otherwise specified)

IGBT

<i>Parameter</i>	<i>Symbol</i>	<i>Value</i>	<i>Unit</i>
Collector Emitter Voltage	V_{CES}	3300	V
Gate – Emitter Voltage	V_{GES}	± 20	V
Collector Current $T_c = 25^\circ\text{C}$	I_C	1500	A
$T_c = 100^\circ\text{C}$		800	
Pulsed Collector Current $t_p = 1\text{ms}$	I_{CM}	1600	A
Maximum Power Dissipation @ $T_J = 150^\circ\text{C}$	P_D	9.62	kW

Diode

<i>Parameter</i>	<i>Symbol</i>	<i>Value</i>	<i>Unit</i>
Repetitive Peak Reverse Voltage	V_{RRM}	3300	V
Diode Continuous Forward Current	I_F	800	A
Diode Maximum Forward Current $t_p = 1\text{ms}$	I_{FM}	1600	A

Module

<i>Parameter</i>	<i>Symbol</i>	<i>Value</i>	<i>Unit</i>
Maximum Junction Temperature	T_{jmax}	150	$^\circ\text{C}$
Operating Junction Temperature	T_{jop}	$-40 \text{ to } +125$	$^\circ\text{C}$
Storage Temperature Range	T_{STG}	$-40 \text{ to } +125$	$^\circ\text{C}$
Isolation Voltage RMS, $f = 50\text{Hz}$, $t = 1\text{min}$	V_{ISO}	6000	V
Partial Discharge Extinction Voltage IEC1287, RMS, $f = 50\text{Hz}$, $Q_{PD} \leq 10\text{pC}$	V_{ISO}	2600	V

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IGBT Characteristics

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
$V_{CE(sat)}$	Collector to Emitter Saturation Voltage	$I_C = 800A, V_{GE} = 15V, T_J = 25^\circ C$		3.10	3.40	V
		$I_C = 800A, V_{GE} = 15V, T_J = 125^\circ C$		3.80		
$V_{GE(th)}$	Gate Emitter Threshold Voltage	$I_C = 160mA, V_{GE} = V_{CE}, T_J = 25^\circ C$	5.5		7.5	V
I_{CES}	Collector Cut – Off Current	$V_{CE} = V_{CES}, V_{GE} = 0V, T_J = 25^\circ C$			12.0	mA
I_{GES}	Gate – Emitter Leakage Current	$V_{GE} = V_{GES}, V_{CE} = 0V, T_J = 25^\circ C$			500	nA
C_{ies}	Input Capacitance	$V_{GE} = 25V, f = 1MHz, V_{CE} = 0V$		125		nF
C_{res}	Reverse Transfer Capacitance			1.48		nF
Q_G	Gate Charge	$V_{GE} = 1800V$ $V_{GE} = -15V \text{ to } +15V$		8.07		μC
$t_{d(on)}$	Turn – On Delay time	$V_{CC} = 1800V$ $I_C = 800A$ $R_G = 2.2\Omega$ $V_{GE} = \pm 15V$ $T_J = 25^\circ C$		525		ns
t_r	Rise time			190		
$t_{d(off)}$	Turn – off Delay time			1050		
t_f	fall time			340		
E_{on}	Turn – on switching loss	$V_{CC} = 1800V$ $I_C = 800A$ $R_G = 1.2\Omega$ $V_{GE} = \pm 15V$ $T_J = 125^\circ C$		1000		mJ
E_{off}	Turn – off switching loss			880		
$t_{d(on)}$	Turn – On Delay time			530		ns
t_r	Rise time			200		
$t_{d(off)}$	Turn – off Delay time	$t_p \leq 10\mu s, V_{GE} = 15V, T_J = 125^\circ C, V_{CC} = 2500V, V_{CEM} \leq 3300V$		1200		
t_f	fall time			460		
E_{on}	Turn – on switching loss			1380		mJ
E_{off}	Turn – off switching loss			1250		
I_{sc}	SC Data	$t_p \leq 10\mu s, V_{GE} = 15V, T_J = 125^\circ C, V_{CC} = 2500V, V_{CEM} \leq 3300V$		3300		A

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Diode Characteristics

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
V_F	Diode Forward Voltage	$I_F = 800A$, $V_{GE} = 0V$ $T_j = 25^\circ C$		2.30	2.60	V
		$I_F = 800A$, $V_{GE} = 0V$ $T_j = 125^\circ C$		2.35		
Q_r	Recovered Charge	$V_R = 1800V$ $I_F = 800A$		710		μC
I_{RM}	Peak Reverse Recovery Current	$\frac{di}{dt} = 4200A/\mu s$ $V_{GE} = -15V$ $T_j = 25^\circ C$		500		A
E_{rec}	Reverse Recovery Energy			620		mJ
Q_r	Recovered Charge	$V_R = 1800V$ $I_F = 800A$		950		μC
I_{RM}	Peak Reverse Recovery Charge	$\frac{di}{dt} = 4200A/\mu s$ $V_{GE} = -15V$ $T_j = 125^\circ C$		925		A
E_{rec}	Reverse Recovery Energy			1180		mJ

Module Characteristics

Symbol	Parameter	Min	Typ	Max	Unit
L_{CE}	Stray Inductance		20		nH
$R_{CC'+R_{\theta JC}}$	Module Lead Resistance, Terminal to Chip		0.18		m Ω
$R_{\theta JC}$	Junction to Case (per IGBT) Junction to Case (per Diode)			13.0 25.0	K/kW
$R_{\theta CS}$	Case – to – Sink (per IGBT) Case – to – Sink (per Diode)		12.2 23.4		K/kW
$R_{\theta CS}$	Case – to – Sink		8.0		K/kW
M	Terminal Connection Torque, Screw M4 Terminal Connection Torque, Screw M8 Mounting Torque, Screw M6	1.8 8.0 4.25		2.1 10 5.75	Nm
G	Weight of Module		1050		g

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Figure 1: IGBT Output Characteristics

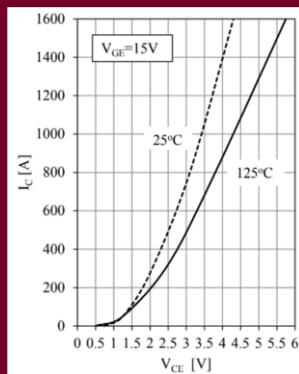


Figure 2: IGBT

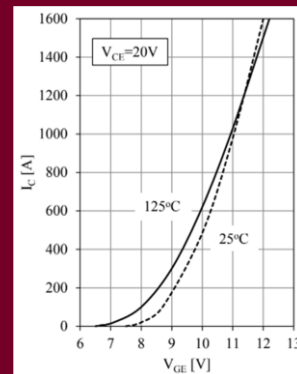


Figure 3: IGBT Switching Loss vs Ic

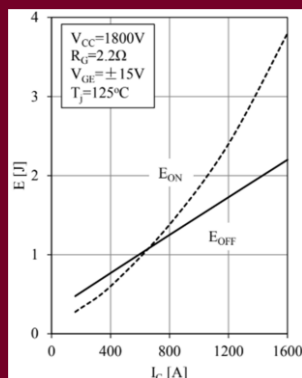
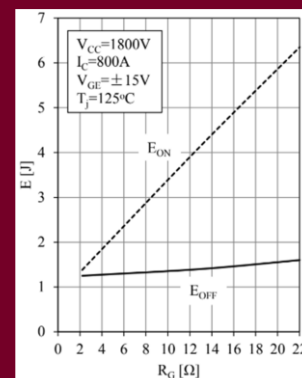


Figure 4: IGBT Switching Loss vs Rg



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Figure 5: RBSOA

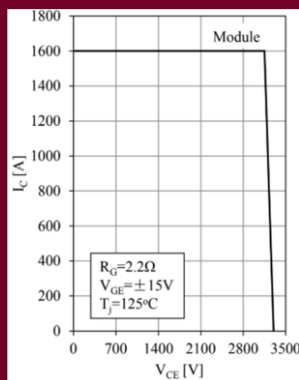


Figure 6: IGBT Transient Thermal Impedance

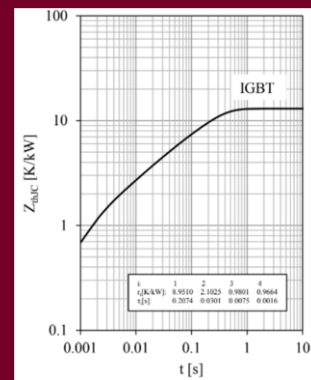


Figure 7: Diode Forward Characteristics

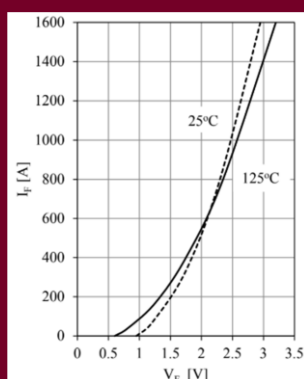
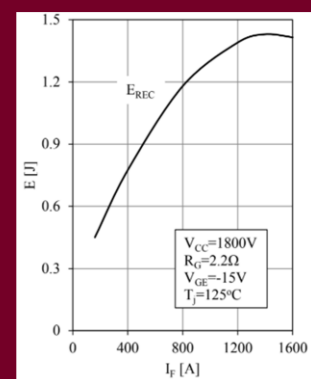


Figure 8: IGBT Switching Loss vs IF



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Figure 9: Diode switching loss vs RG

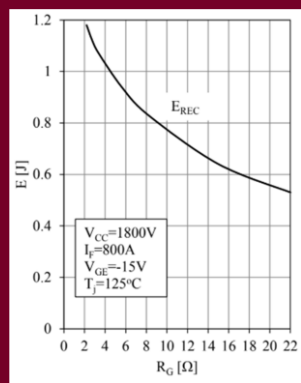
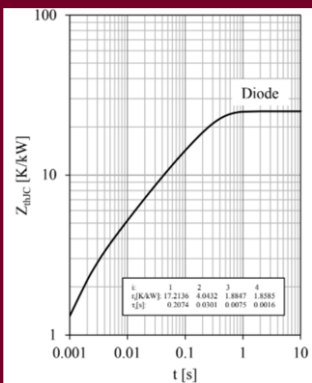


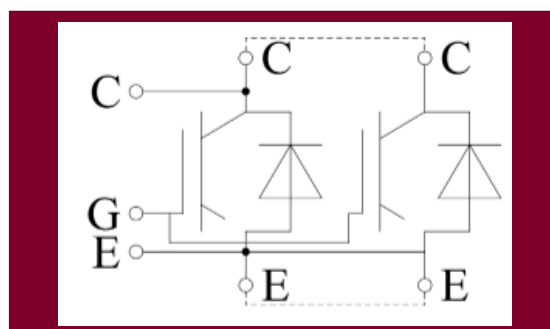
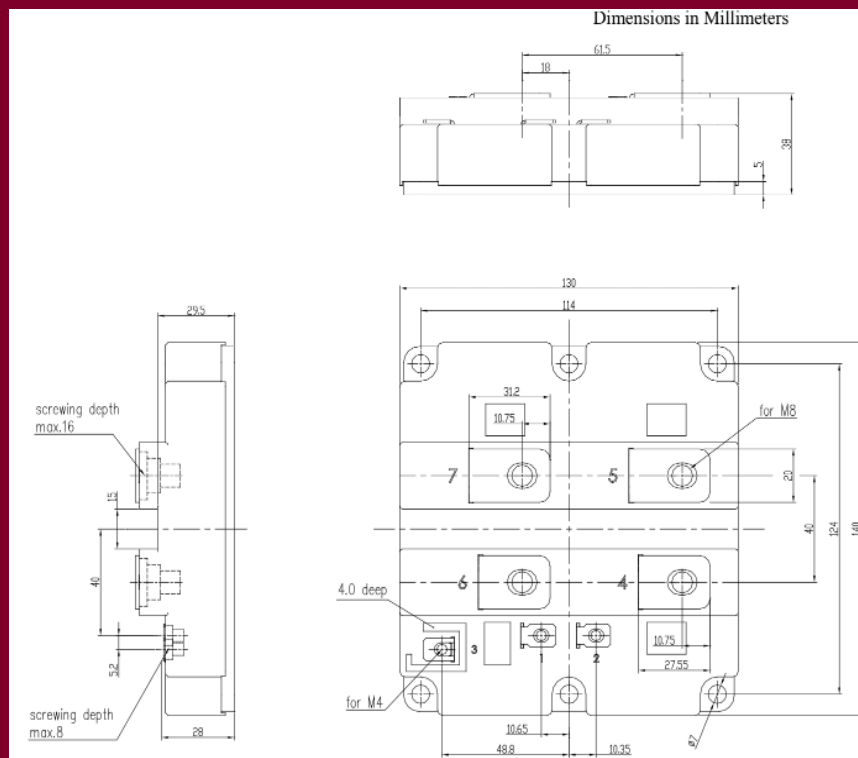
Figure 10: Diode transient thermal impedance



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